Search Notes



Applicant(s)/Patent Under
Reexamination

10581589 KOYAMA, RIKA

Examiner Art Unit

3744

SEARCHED Class Subclass Date Examiner 62 157 701 1,36 367 198 460,825.24,825.19 340 704 275,243 6/24/10 CJ

Chen-Wen Jiang

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Searched		
Inventor Searched	6/24/10	CJ

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20100624